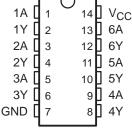
- EPIC<sup>™</sup> (Enhanced-Performance Implanted CMOS) Submicron Process
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Latch-Up Performance Exceeds 250 mA Per JESD 17
- Typical V<sub>OLP</sub> (Output Ground Bounce)
   < 0.8 V at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25°C
- Typical V<sub>OHV</sub> (Output V<sub>OH</sub> Undershoot)
   2 V at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25°C
- Inputs Accept Voltages to 5.5 V
- Package Options Include Plastic Small-Outline (D), Shrink Small-Outline (DB), and Thin Shrink Small-Outline (PW) Packages

### 



#### description

This hex inverter is designed for 1.65-V to 3.6-V  $V_{CC}$  operation.

The SN74LVCU04A contains six independent inverters with unbuffered outputs, and performs the Boolean function  $Y = \overline{A}$ .

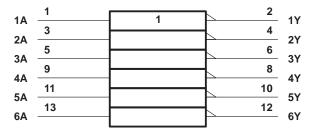
Inputs can be driven from either 3.3-V or 5-V devices. This feature allows the use of these devices as translators in a mixed 3.3-V/5-V system environment.

The SN74LVCU04A is characterized for operation from -40°C to 85°C.

### FUNCTION TABLE (each inverter)

| INPUT<br>A | OUTPUT<br>Y |
|------------|-------------|
| Н          | L           |
| L          | Н           |

### logic symbol†



<sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.



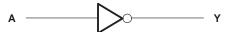
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#### logic diagram, each inverter (positive logic)



### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

| Supply voltage range, V <sub>CC</sub>                            |         |
|--|---------|
| Input voltage range, V <sub>I</sub> (see Note 1)                 |         |
| Output voltage range, VO (see Notes 1 and 2)                     |         |
| Input clamp current, $I_{IK}$ ( $V_I < 0$ )                      |         |
| Output clamp current, I <sub>OK</sub> (V <sub>O</sub> < 0)       |         |
| Continuous output current, IO                                    | ±50 mA  |
| Continuous current through V <sub>CC</sub> or GND                | ±100 mA |
| Package thermal impedance, $\theta_{JA}$ (see Note 3): D package | 127°C/W |
| DB package   | 158°C/W |
| PW package   | 170°C/W |
| Storage temperature range, T <sub>stq</sub>                      |         |

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

- 2. The value of V<sub>CC</sub> is provided in the recommended operating conditions table.
- 3. The package thermal impedance is calculated in accordance with JESD 51.



### recommended operating conditions (see Note 4)

|                |  |                                  | MIN  | MAX  | UNIT |  |
|----------------|--|----------------------------------|------|------|------|--|
| VCC            | Operating                                |                                  | 1.65 | 3.6  | V    |  |
|                | Supply voltage Data retention only       | Data retention only              | 1.5  |      | V    |  |
|                |  | V <sub>CC</sub> = 1.65 V         | 1.32 |      |      |  |
|                | V <sub>IH</sub> High-level input voltage | V <sub>CC</sub> = 2.3 V          | 1.84 |      |      |  |
| $V_{IH}$       |  | V <sub>CC</sub> = 2.7 V          | 2.16 |      | V    |  |
|                |  | V <sub>CC</sub> = 3 V            | 2.4  |      |      |  |
|                |  | V <sub>CC</sub> = 3.6 V          | 2.88 |      |      |  |
|                |  | V <sub>CC</sub> = 1.65 V         |      | 0.4  |      |  |
| $V_{IL}$       | Low-level input voltage                  | V <sub>CC</sub> = 2.3 V          |      | 0.5  | V    |  |
|                |  | V <sub>CC</sub> = 2.7 V to 3.6 V |      | 0.65 |      |  |
| ٧ <sub>I</sub> | Input voltage                            | •                                | 0    | 5.5  | V    |  |
| Vo             | Output voltage                           |                                  | 0    | Vcc  | V    |  |
|                |  | V <sub>CC</sub> = 1.65 V         |      | -4   |      |  |
|                |  | V <sub>CC</sub> = 2.3 V          |      | -8   |      |  |
| IOH            | High-level output current                | V <sub>CC</sub> = 2.7 V          |      | -12  | mA   |  |
|                |  | V <sub>CC</sub> = 3 V            |      | -24  |      |  |
|                |  | V <sub>CC</sub> = 1.65 V         |      | 4    |      |  |
|                | Low-level output current                 | V <sub>CC</sub> = 2.3 V          |      | 8    |      |  |
| lOL            |  | V <sub>CC</sub> = 2.7 V          |      | mA   |      |  |
|                |  | V <sub>CC</sub> = 3 V            |      | 24   |      |  |
| Δt/Δν          | Input transition rise or fall rate       |                                  | 0    | 10   | ns/V |  |
| TA             | Operating free-air temperature           |                                  | -40  | 85   | °C   |  |

NOTE 4: All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER       | TEST C                                | ONDITIONS                              | v <sub>cc</sub> | MIN                  | TYP† | MAX  | UNIT |  |
|-----------------|---------------------------------------|--|-----------------|----------------------|------|------|------|--|
|                 | I <sub>OH</sub> = -100 μA             |  | 1.65 V to 3.6 V | V <sub>CC</sub> -0.2 |      |      |      |  |
|                 | $I_{OH} = -4 \text{ mA},$             | V <sub>IL</sub> = 0.4 V                | 1.65 V          | 1.2                  |      |      |      |  |
| \/              | $I_{OH} = -8 \text{ mA},$             | V <sub>IL</sub> = 0.5 V                | 2.3 V           | 1.7                  |      |      | V    |  |
| VOH             | lou - 12 mA                           | \\ 0.05\\                              | 2.7 V           | 2.2                  |      |      |      |  |
|                 | $I_{OH} = -12 \text{ mA},$            | V <sub>IL</sub> = 0.65 V               | 3 V             | 2.4                  |      |      |      |  |
|                 | I <sub>OH</sub> = -24 mA              |  | 3 V             | 2.2                  |      |      |      |  |
|                 | I <sub>OL</sub> = 100 μA              |  | 1.65 V to 3.6 V |                      |      | 0.2  |      |  |
|                 | $I_{OL} = 4 \text{ mA},$              | V <sub>IH</sub> = 1.32 V               | 1.65 V          |                      |      | 0.45 |      |  |
| V <sub>OL</sub> | I <sub>OL</sub> = 8 mA,               | V <sub>IH</sub> = 1.84 V               | 2.3 V           |                      |      | 0.7  | V    |  |
|                 | I <sub>OL</sub> = 12 mA,              | V <sub>IH</sub> = 2.16 V               | 2.7 V           |                      |      | 0.4  |      |  |
|                 | I <sub>OL</sub> = 24 mA,              | V <sub>IH</sub> = 2.4 V                | 3 V             |                      |      | 0.55 |      |  |
| lį              | $V_I = 5.5 \text{ V or GND}$          |  | 3.6 V           |                      |      | ±5   | μΑ   |  |
| lcc             | $V_I = V_{CC}$ or GND,                | I <sub>O</sub> = 0                     | 3.6 V           |                      |      | 10   | μΑ   |  |
| ΔlCC            | One input at V <sub>CC</sub> – 0.6 V, | Other inputs at V <sub>CC</sub> or GND | 2.7 V to 3.6 V  |                      |      | 500  | μΑ   |  |
| Ci              | $V_I = V_{CC}$ or GND                 |  | 3.3 V           |                      | 5    |      | pF   |  |

 $<sup>\</sup>uparrow$  All typical values are at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25°C.



# switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figures 1 through 3)

| PARAMETER       | FROM<br>(INPUT)  | TO<br>(OUTPUT) | V <sub>CC</sub> = 1.8 V | V <sub>CC</sub> = 2.5 V<br>± 0.2 V |     | V <sub>CC</sub> = 2.5 V<br>± 0.2 V |     | V <sub>CC</sub> = 2.7 V |     | V <sub>CC</sub> = 3.3 V<br>± 0.3 V |    | UNIT |
|-----------------|------------------|----------------|-------------------------|------------------------------------|-----|------------------------------------|-----|-------------------------|-----|------------------------------------|----|------|
|                 |                  |                | TYP                     | MIN                                | MAX | MIN                                | MAX | MIN                     | MAX |                                    |    |      |
| tpd             | I                | А              | Υ                       | 12.7                               | 1   | 6.7                                |     | 4.7                     | 1   | 3.8                                | ns |      |
| <sup>t</sup> sk | (o) <sup>†</sup> |                |                         |                                    |     |                                    |     |                         |     | 1                                  | ns |      |

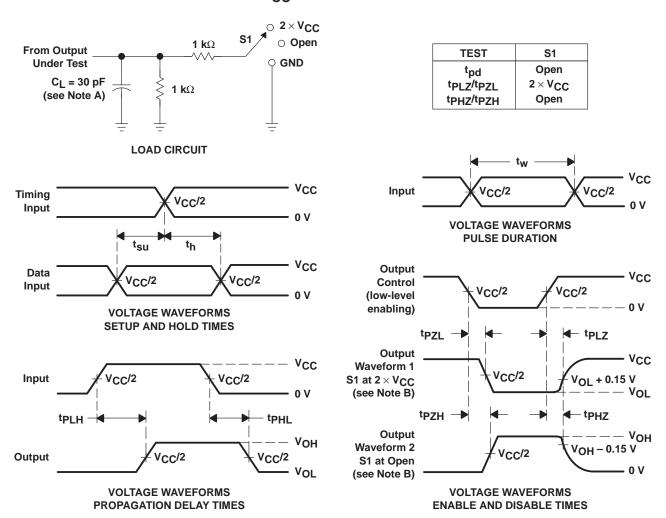
<sup>†</sup> Skew between any two outputs of the same package switching in the same direction

### operating characteristics, $T_A = 25^{\circ}C$

| PARAMETER       |  | TEST       | V <sub>CC</sub> = 1.8 V | V <sub>CC</sub> = 2.5 V | V <sub>CC</sub> = 3.3 V | UNIT |
|-----------------|--|------------|-------------------------|-------------------------|-------------------------|------|
|                 |  | CONDITIONS | TYP                     | TYP                     | TYP                     | ONIT |
| C <sub>pd</sub> | Power dissipation capacitance per inverter | f = 10 MHz | 3                       | 4                       | 5                       | pF   |



## PARAMETER MEASUREMENT INFORMATION $V_{CC} = 1.8 \text{ V} \pm 0.15 \text{ V}$

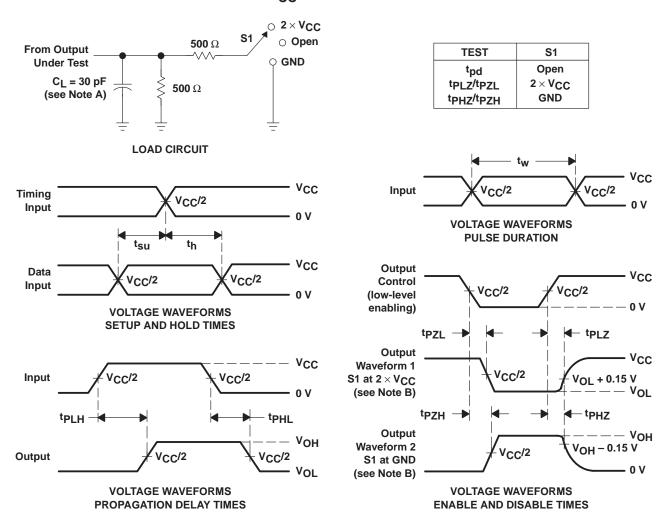


NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_O = 50~\Omega$ ,  $t_f \leq$  2 ns.  $t_f \leq$  2 ns.
- D. The outputs are measured one at a time with one transition per measurement.
- E. tpLz and tpHz are the same as tdis.
- F. tpzL and tpzH are the same as ten.
- G. tpLH and tpHL are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms

### PARAMETER MEASUREMENT INFORMATION $V_{CC} = 2.5 \text{ V} \pm 0.2 \text{ V}$



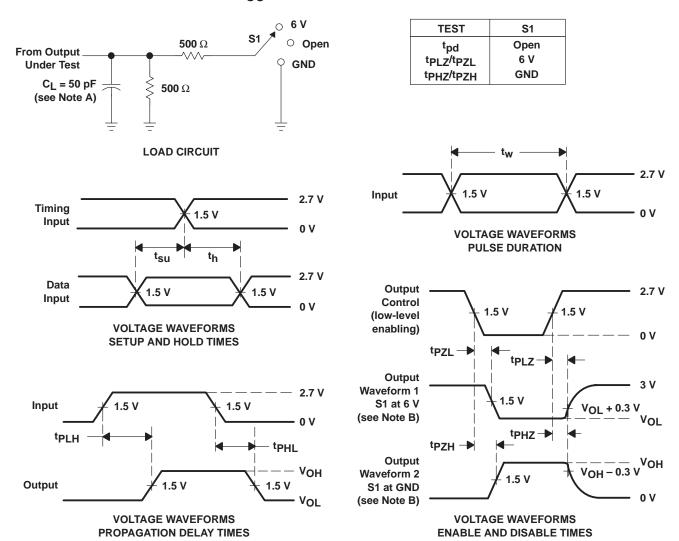
NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_O = 50 \Omega$ ,  $t_f \leq 2$  ns.
- D. The outputs are measured one at a time with one transition per measurement.
- E. tpLz and tpHz are the same as tdis.
- F. tpzl and tpzH are the same as ten.
- G. tpLH and tpHL are the same as tpd.

Figure 2. Load Circuit and Voltage Waveforms



### PARAMETER MEASUREMENT INFORMATION $V_{CC}$ = 2.7 V AND 3.3 V $\pm$ 0.3 V



- NOTES: A.  $C_L$  includes probe and jig capacitance.
  - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
  - C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_0 = 50 \Omega$ ,  $t_r \leq$  2.5 ns,  $t_f \leq$  2.5 ns.
  - D. The outputs are measured one at a time with one transition per measurement.
  - E. tpLZ and tpHZ are the same as tdis.
  - F. tpzL and tpzH are the same as ten.
  - G. tpLH and tpHL are the same as tpd.

Figure 3. Load Circuit and Voltage Waveforms

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